

**Notice of References Cited**

Application/Control No. <b>09/867,286</b>		Applicant(s)/Patent Under Reexam <b>Ried et al.</b>	
Examiner <b>H. Kwok</b>	Art Unit <b>2856</b>	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,652,384	7/1997	Henrion et al.	73	514.24
B	US 2002/0178817	12/2002	Selvakumar et al.	73	514.32
C					
D					
E					
F					
G					
H					
I					
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K					
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**FOREIGN PATENT DOCUMENTS**

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N						
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**NON-PATENT DOCUMENTS**

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